

<b>Notice of References Cited</b>	Application/Control No. 10/056,294	Applicant(s)/Patent Under Reexamination ROY ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,542,744	04-2003	Lin, Ham-Jier	455/437
	B	US-2002/0068570	06-2002	Abrol et al.	455/438
	C	US-6,167,035	12-2000	Veeravalli et al.	370/331
	D	US-2002/0009991	01-2002	Lu et al.	455/422
	E	US-6,128,287	10-2000	Freeburg et al.	370/331
	F	US-6,490,259	12-2002	Agrawal et al.	370/331
	G	US-6,570,856	05-2003	Freeburg et al.	370/310.1
	H	US-5,513,183	04-1996	Kay et al.	370/337
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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